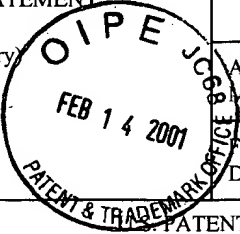

















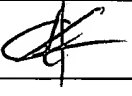




Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 106539		APPLICATION NO. 09/731,671	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)							
				APPLICANT(S) Michael NAHUM et al.			
				FILING DATE December 8, 2000			GROUP
PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
		4,794,384	12/88	JACKSON	—	—	
		4,967,093	10/90	TAKEMORI	—	—	
		4,671,650	06/87	HIRZEL et al.	—	—	
		5,453,840	09/95	PARKER et al.	—	—	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
		JP-56-26208 w/Eng. Abstract	03/81	JAPAN	—	—	
		JP-8-14,824 w/Eng. Abstract	01/96	JAPAN	—	—	
		JP-2-297,006 w/Eng. Abstract	12/90	JAPAN	—	—	
		JP-8-261,730 w/Eng. Abstract	10/96	JAPAN	—	—	
		JP-3-274,401 w/Eng. Abstract	12/91	JAPAN	—	—	
		JP-8-261,717 w/Eng. Abstract	10/96	JAPAN	—	—	
		JP-4-131,705 w/Eng. Abstract	05/92	JAPAN	—	—	
		JP-8-233,522 w/Eng. Abstract	09/96	JAPAN	—	—	
		JP-7-151,516 w/Eng. Abstract	06/95	JAPAN	—	—	
		JP-60-71911 w/Eng. Abstract	4/85	JAPAN	—	—	
		JP-8-271231 w/Eng. Abstract	10/96	JAPAN	—	—	
		JP-5-52517 w/Eng. Abstract	03/93	JAPAN	—	—	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
		YAMAGUCHI, Ichiro et al., "Linear and Rotary Encoders Using Electronic Speckle Correlation," <u>Optical Engineering</u>, Vol. 30, No. 12, 1991					
		SUTTON, Michael A. et al., "Effects of Subpixel Image Restoration on Digital Correlation Error Estimates," <u>Optical Engineering</u> , Vol. 27, No. 10, 1988					
		SJÖDAHL, M. "Accuracy in Electronic Speckle Photography," <u>Applied Optics</u> , Vol. 36, No. 13, 1997					
		SCHREIER, Hubert et al. "Systematic Errors in Digital Image Correlation Caused by Intensity Interpolation," <u>Optical Engineering</u> , Vol. 39, No. 11, November 2000					
EXAMINER 				DATE CONSIDERED 2/20/04			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							